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Key indicators

Single-crystal X-ray study T = 273 K Mean σ (C–C) = 0.004 Å R factor = 0.059 wR factor = 0.140 Data-to-parameter ratio = 16.6

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

N-(2-Chlorophenyl)-*N*'-(4-methoxybenzoyl)-thiourea

In the title compound, $C_{15}H_{13}CIN_2O_2S$, the dihedral angle between the 2-chlorophenyl and 4-methoxyphenyl groups is 54.12 (13)°. The molecule is stabilized by intermolecular C– H···S and N–H···S interactions, forming double-column chains arranged parallel to the *b* axis. Received 17 August 2004 Accepted 4 October 2004 Online 16 October 2004

Comment

The molecular structure and dimensions of the title compound, (I), are similar to those of other benzoylthiourea derivatives, such as *N*-benzoyl-*N'*-(2-chlorophenyl)thiourea (Yusof & Yamin, 2004) and *N*-benzoyl-*N'*-phenylthiourea (Yamin & Yusof, 2003). The molecule maintains its *cis*-*trans* configuration with respect to the position of the 4-methoxy-phenyl and 2-chlorophenyl groups relative to the S atom across the thiourea C–N bonds.



The central carbonylthiourea moiety (S1/C8/N1/N2/C9/O1), 4-methoxyphenyl (C1–C6/O2/C15) and 2-cholorophenyl (C9– C14/C11) fragments are each planar, the maximum deviation being 0.075 (3) Å for atom C15. The central carbonylthiourea moiety makes dihedral angles of 9.91 (10) and 44.23 (11)°, respectively, with the 4-methoxyphenyl and 2-chlorophenyl fragments. This can be compared with values of 11.96 (9) and 29.36 (8)° for the same angles in *N*-benzoyl-*N*'-(2-chlorophenyl)thiourea. However, the dihedral angle between the 4methoxyphenyl and 2-chlorophenyl fragments of 54.12 (13)° is



Figure 1

The molecular structure of compound (I), shown with 50% probability displacement ellipsoids. Dashed lines indicate intramolecular hydrogen bonds.

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larger than the value of $38.67 (10)^{\circ}$ for *N*-benzoyl-*N'*-(2-chlorophenyl)thiourea.

There are two intramolecular hydrogen bonds, N2– H2···O1 and C14–H14···S1 (Table 2), and as a result, two pseudo-six-membered rings (S1–C8–N2–C9–C14–H14 and O1–C7–N1–C8–N2–H2) are formed. In the crystal structure, the molecules are linked by intermolecular interactions, C1–H1A···S1ⁱ and N1–H1···S1ⁱⁱ [symmetry codes: (i) $\frac{3}{2} - x$, $y - \frac{1}{2}$, $\frac{1}{2} - z$; (ii) $\frac{3}{2} - x$, $\frac{1}{2} + y$, $\frac{1}{2} - z$; Table 2], forming double-column chains along the *b* axis.

Experimental

A solution of 2-(chlorophenyl)aniline (2.00 g, 0.016 mol) in acetone (50 ml) was added dropwise to an acetone solution (50 ml) containing an equimolar amount of 4-methoxyphenylbenzoyl isothiocyanate in a two-necked round-bottomed flask. The solution was refluxed for about 2 h and then cooled in ice. The white precipitate was filtered off and washed with ethanol–distilled water, then dried in a vacuum (yield 87%). Recrystallization from ethanol yielded single crystals suitable for X-ray analysis.

Crystal data

$C_{15}H_{13}CIN_2O_2S$ $M_r = 320.78$	$D_x = 1.453 \text{ Mg m}^{-3}$ Mo $K\alpha$ radiation
Monoclinic, $P2_1/n$ a = 13.438 (3) Å b = 3.9893 (9) Å c = 27.727 (6) Å $\beta = 99.508$ (4)° V = 1466.0 (5) Å ³ Z = 4	Cell parameters from 2167 reflections $\theta = 1.5-27.0^{\circ}$ $\mu = 0.41 \text{ mm}^{-1}$ T = 273 (2) K Block, colourless $0.22 \times 0.19 \times 0.16 \text{ mm}$
Data collection	
Bruker SMART APEX CCD area- detector diffractometer ω scans Absorption correction: multi-scan (<i>SADABS</i> ; Sheldrick, 1996) $T_{\rm min} = 0.916, T_{\rm max} = 0.938$ 7879 measured reflections	3162 independent reflections 2649 reflections with $I > 2\sigma(I)$ $R_{int} = 0.024$ $\theta_{max} = 27.0^{\circ}$ $h = -13 \rightarrow 17$ $k = -5 \rightarrow 5$ $l = -35 \rightarrow 27$
Refinement	
Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.059$ $wR(F^2) = 0.140$ S = 1.19 3162 reflections 191 parameters H-atom parameters constrained	$\begin{split} w &= 1/[\sigma^2(F_o{}^2) + (0.0589P)^2 \\ &+ 0.3777P] \\ \text{where } P &= (F_o{}^2 + 2F_c{}^2)/3 \\ (\Delta/\sigma)_{\text{max}} &= 0.001 \\ \Delta\rho_{\text{max}} &= 0.33 \text{ e } \text{\AA}{}^{-3} \\ \Delta\rho_{\text{min}} &= -0.18 \text{ e } \text{\AA}{}^{-3} \end{split}$
Table 1	

			0		
Selected	geometric	parameters	(À.	0)	1

Cl1-C10	1.731 (3)	N1-C8	1.386 (3)
S1-C8	1.662 (2)	N2-C8	1.331 (3)
N1-C7	1.377 (3)	N2-C9	1.415 (3)
C9-N2-C8-N1	-179.3 (2)	C7-N1-C8-S1	177.4 (2)



Figure 2

Packing diagram of (I), viewed down the *c* axis. Dashed lines indicate the $C-H\cdots S$ hydrogen bonds.

Table 2			
Hydrogen-bonding geometry	(Å,	°).	

$D - H \cdot \cdot \cdot A$	D-H	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdots A$
N2-H2···O1	0.86	1.93	2.638 (3)	138
$C14-H14\cdots S1$	0.93	2.80	3.209 (3)	107
$C1-H1B\cdots S1^{i}$	0.93	2.80	3.686 (3)	160
$N1 - H1A \cdots S1^{ii}$	0.86	2.87	3.478 (3)	129

Symmetry codes: (i) $\frac{3}{2} - x$, $y - \frac{1}{2}, \frac{1}{2} - z$; (ii) $\frac{3}{2} - x, \frac{1}{2} + y, \frac{1}{2} - z$.

After their location in a difference map, all H atoms were placed geometrically in ideal positions and allowed to ride on the parent atoms, with C-H = 0.93–0.96 Å and N-H = 0.86 Å, and $U_{iso}(H) = 1.5U_{eq}$ (methyl C) or $1.2U_{eq}(C,N)$.

Data collection: *SMART* (Siemens, 1996); cell refinement: *SAINT* (Siemens, 1996); data reduction: *SAINT*; program(s) used to solve structure: *SHELXTL* (Sheldrick, 1997); program(s) used to refine structure: *SHELXTL*; molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*, *PARST* (Nardelli, 1995) and *PLATON* (Spek, 2003).

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